

General Description

The WSD3810DN33 is the highest performance trench Dual N-Channel MOSFET with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications.

The WSD3810DN33 meet the RoHS and Green Product requirement 100% E_{AS} guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% E_{AS} Guaranteed
- Green Device Available

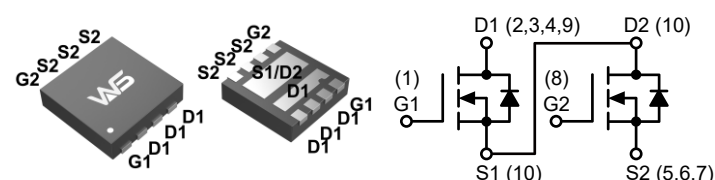
Product Summary

BV_{DSS}	$R_{DS(ON)}$	I_D	I_{TEM}
30V	9.0m Ω	18A	Q1
30V	8.5m Ω	18A	Q2

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

DFN33X33-8S Pin Configuration



Absolute Maximum Ratings ($T_A=25^{\circ}\text{C}$, Unless Otherwise Noted)

Symbol	Parameter	Rating		Units
		Q1	Q2	
V_{DS}	Drain-Source Voltage	30	30	V
V_{GS}	Gate-Source Voltage	± 20	± 20	
I_D	Drain Current (Continuous) ^{1,3}	$T_C=25^{\circ}\text{C}$	18	A
		$T_C=100^{\circ}\text{C}$	12.3	
I_{DM}	Pulsed Drain Current ²	45	45	
E_{AS}	Single Pulse Avalanche Energy	$V_{DD}=25\text{V}$, $V_{GS}=10\text{V}$, $L=1.0\text{mH}$, $R_G=25\Omega$		mJ
P_D	Power Dissipation	$T_C=25^{\circ}\text{C}$	20	W
T_{STG}	Storage Temperature Range	-55 to 150	-55 to 150	$^{\circ}\text{C}$
T_J	Operating Junction Temperature Range	-55 to 150	-55 to 150	

Thermal Data

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	---	6	$^{\circ}\text{C/W}$

Q1 Electrical Characteristics ($T_A=25^{\circ}\text{C}$, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
Static						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250μA	30	---	---	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =30V , V _{GS} =0V	---	---	1.0	μA
I _{GSS}	Gate Leakage Current	V _{GS} =±20V , V _{DS} =0V	---	---	±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _{DS} =250μA	1.0	1.6	2.5	V
R _{DS(ON)}	Drain-Source On-state Resistance	V _{GS} =10V , I _D =10A	---	9.0	10.8	mΩ
		V _{GS} =4.5V , I _D =8A	---	12	17.5	
g _{fs}	Forward Transconductance	V _{DS} =5V , I _D =5A	---	12	---	S
V _{SD}	Diode Forward Voltage	I _{SD} =1A , V _{GS} =0V	---	---	1.3	V
Switching						
Q _g	Total Gate Charge	V _{DS} =15V , V _{GS} =10V , I _D =5A	---	8	---	nC
Q _{gs}	Gate-Source Charge		---	1.6	---	
Q _{gd}	Gate-Drain Charge		---	1.2	---	
T _{d(on)}	Turn-on Delay Time	V _{DD} =15V , V _{GS} =10V , R _G =6Ω , I _D =1A	---	8.5	---	ns
T _r	Turn-on Rise Time		---	10	---	
T _{d(off)}	Turn-off Delay Time		---	14	---	
T _f	Turn-off Fall Time		---	10.6	---	
Dynamic						
C _{iss}	Input Capacitance	V _{DS} =15V , V _{GS} =0V , f = 1.0MHz	---	455	---	pF
C _{oss}	Output Capacitance		---	318	---	
C _{rss}	Reverse Transfer Capacitance		---	22	---	

Note:

1. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}\text{C}$.
The value in any given application depends on the user's specific board design.
2. Repetitive rating, pulse width limited by junction temperature.
3. The current rating is based on the $t \leq 10s$ junction to ambient thermal resistance rating.

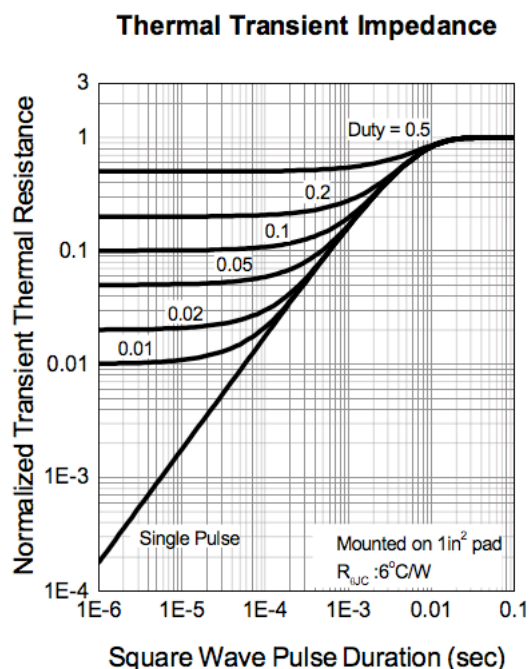
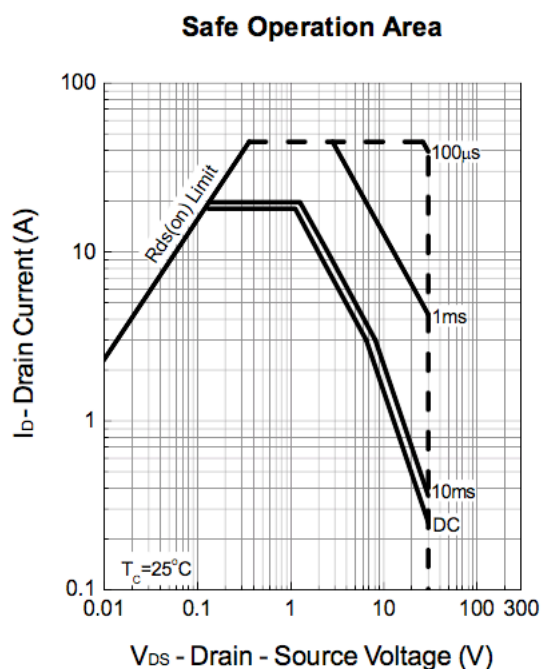
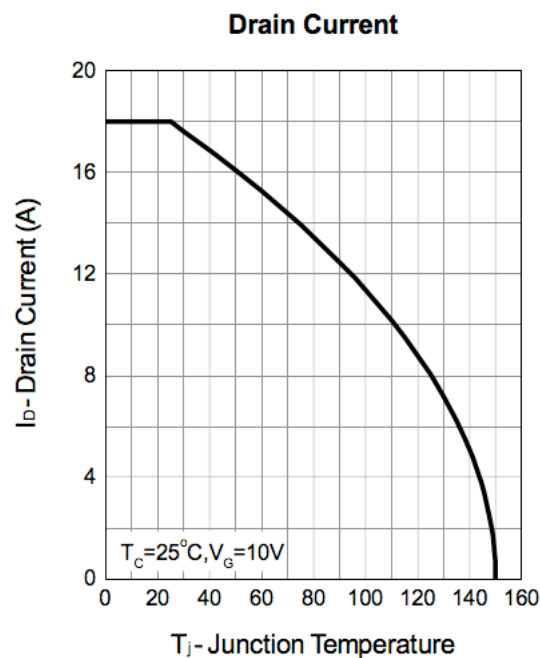
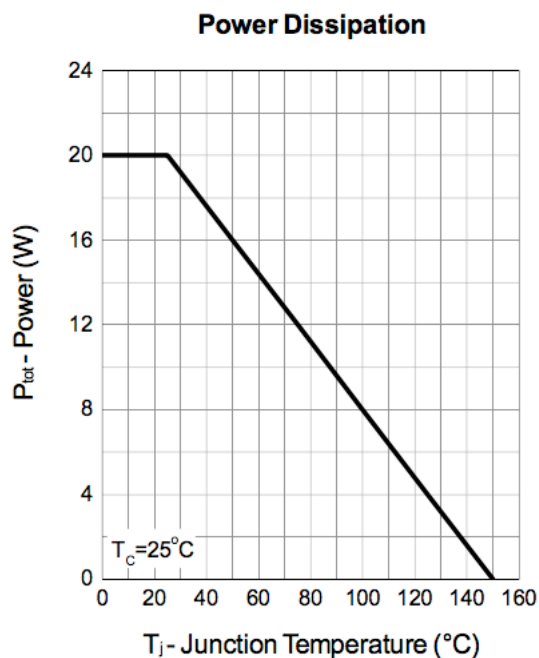
Q2 Electrical Characteristics ($T_A=25^{\circ}\text{C}$, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
Static						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250μA	30	---	---	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =30V , V _{GS} =0V	---	---	1.0	μA
I _{GSS}	Gate Leakage Current	V _{GS} =±20V , V _{DS} =0V	---	---	±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _{DS} =250μA	1.0	1.6	2.5	V
R _{DS(ON)}	Drain-Source On-state Resistance	V _{GS} =10V , I _D =10A	---	8.5	10.5	mΩ
		V _{GS} =4.5V , I _D =8A	---	12.5	16	
g _{fs}	Forward Transconductance	V _{DS} =5V , I _D =5A	---	12	---	S
V _{SD}	Diode Forward Voltage	I _{SD} =1A , V _{GS} =0V	---	---	1.3	V
Switching						
Q _g	Total Gate Charge	V _{DS} =15V , V _{GS} =10V , I _D =5A	---	8	---	nC
Q _{gs}	Gate-Source Charge		---	1.6	---	
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T _{d(on)}	Turn-on Delay Time	V _{DD} =15V , V _{GS} =10V , R _G =6Ω , I _D =1A	---	8.5	---	ns
T _r	Turn-on Rise Time		---	10	---	
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Dynamic						
C _{iss}	Input Capacitance	V _{DS} =15V , V _{GS} =0V , f = 1.0MHz	---	455	---	pF
C _{oss}	Output Capacitance		---	318	---	
C _{rss}	Reverse Transfer Capacitance		---	22	---	

Note:

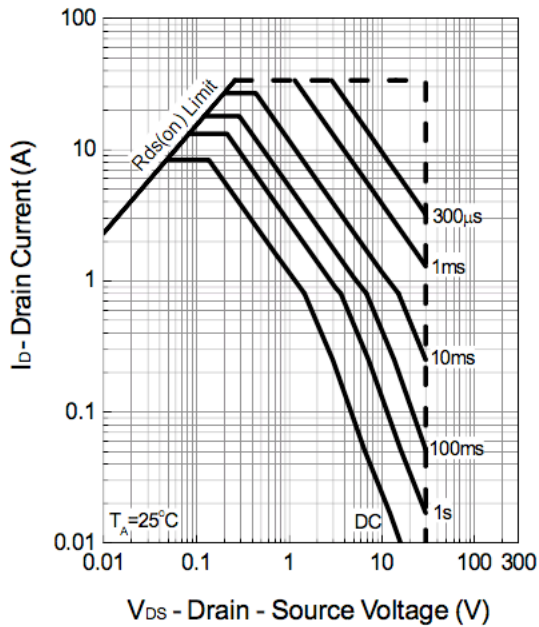
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The value in any given application depends on the user's specific board design.
2. Repetitive rating, pulse width limited by junction temperature.
3. The current rating is based on the $t \leq 10s$ junction to ambient thermal resistance rating.

Q1 Typical Characteristics

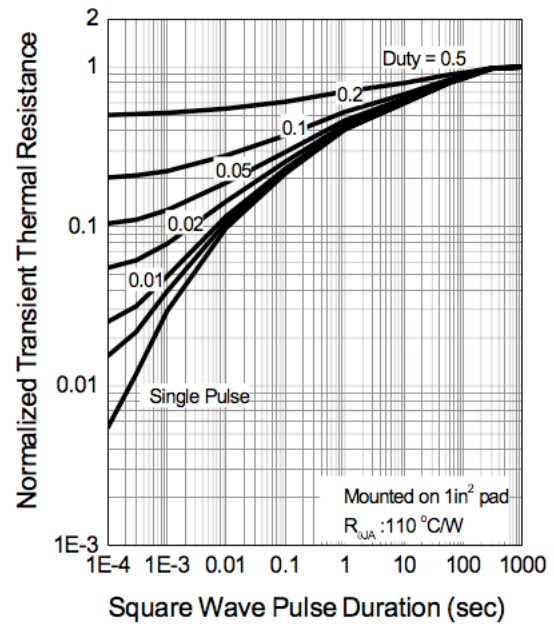


Q1 Typical Characteristics (Cont.)

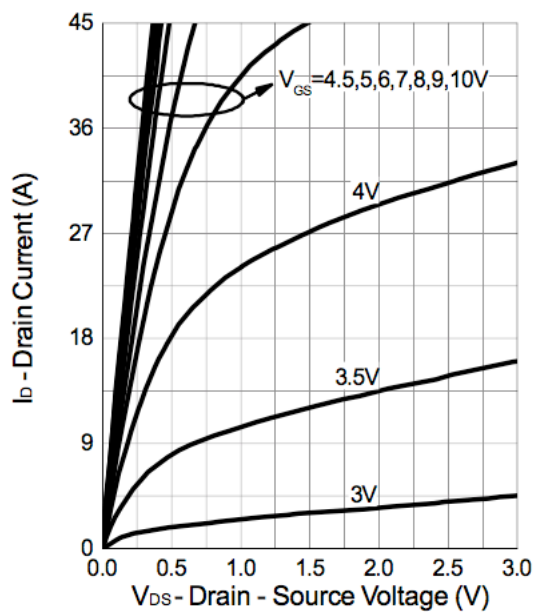
Safe Operation Area



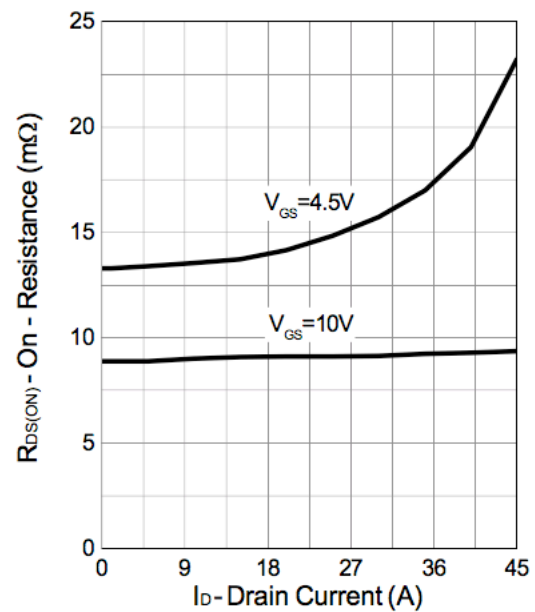
Thermal Transient Impedance

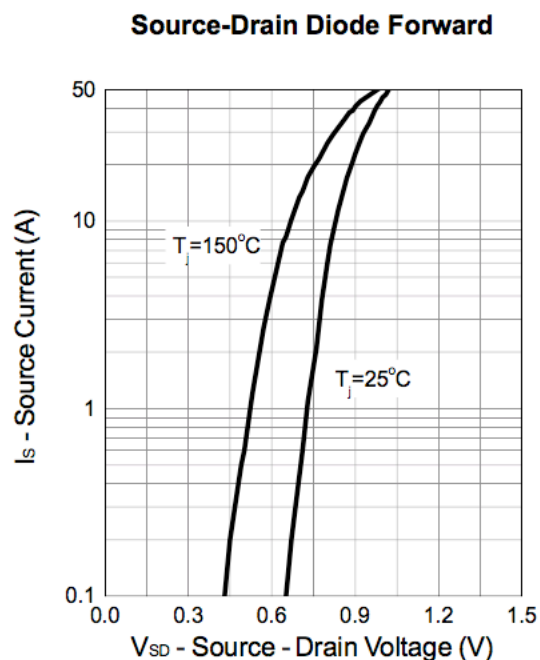
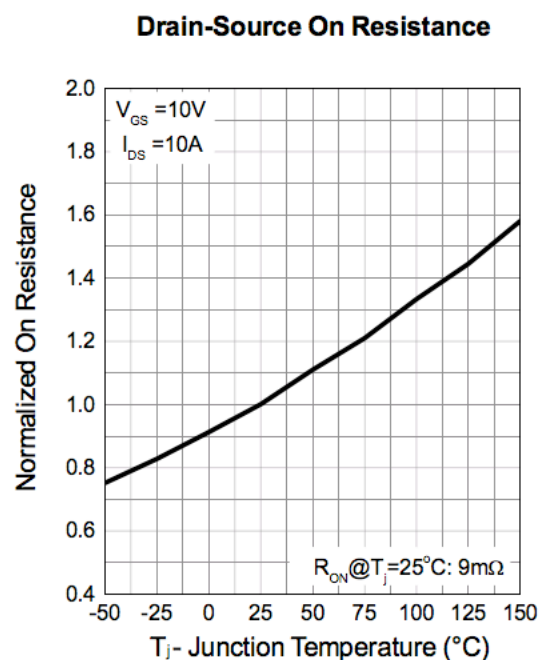
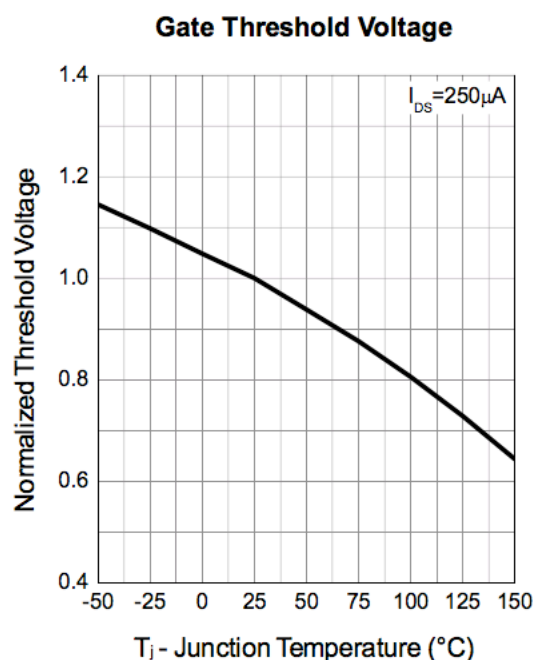
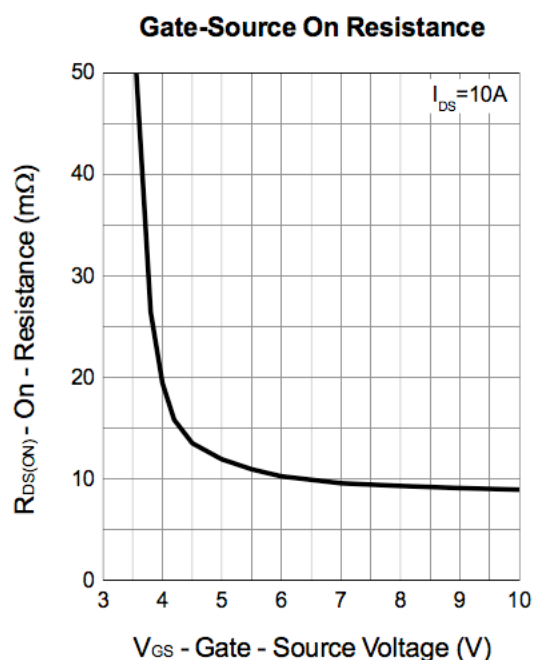


Output Characteristics

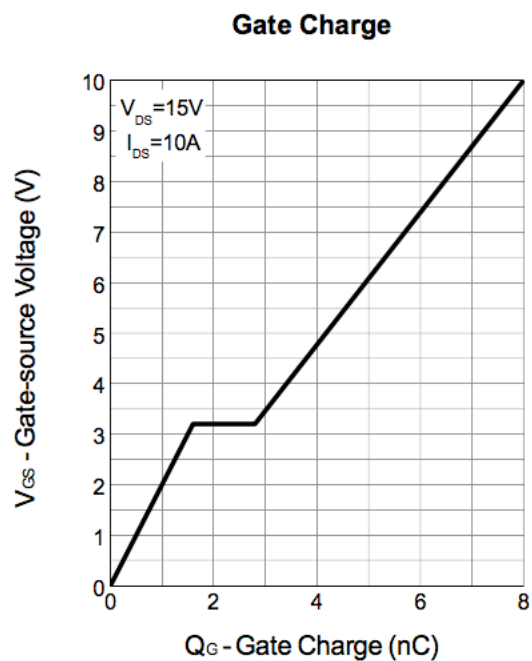
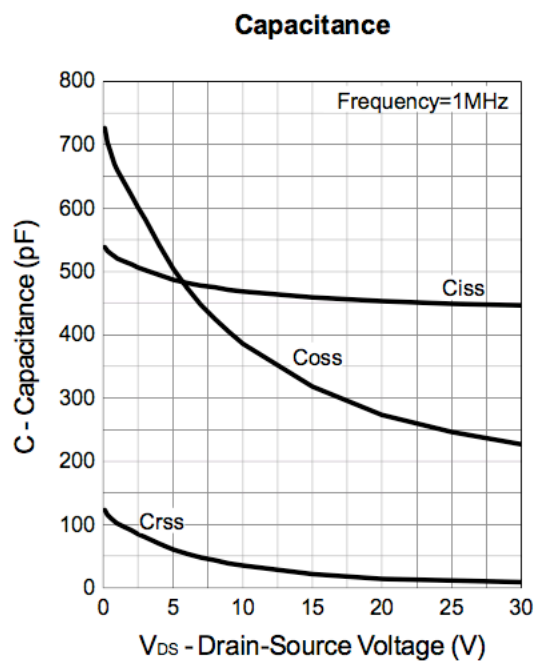


Drain-Source On Resistance

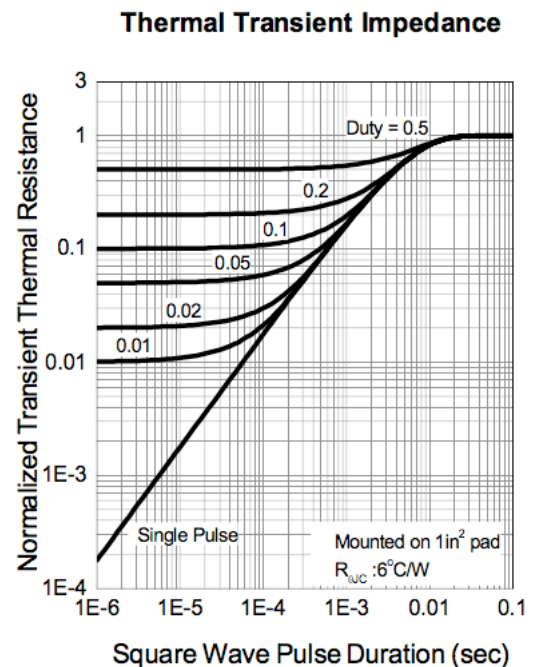
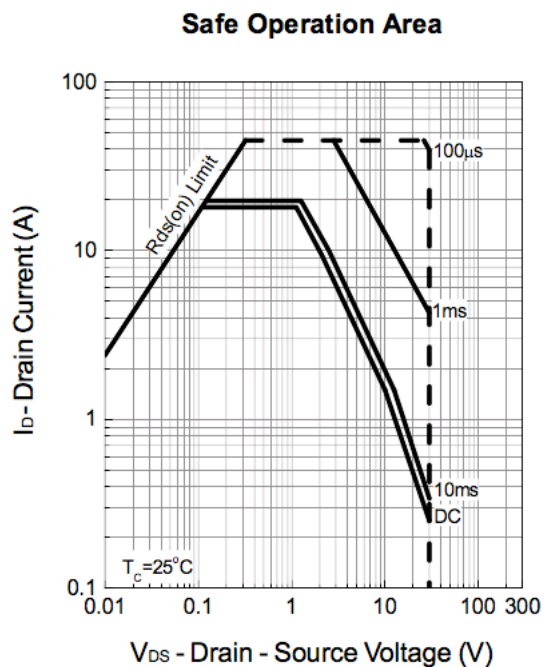
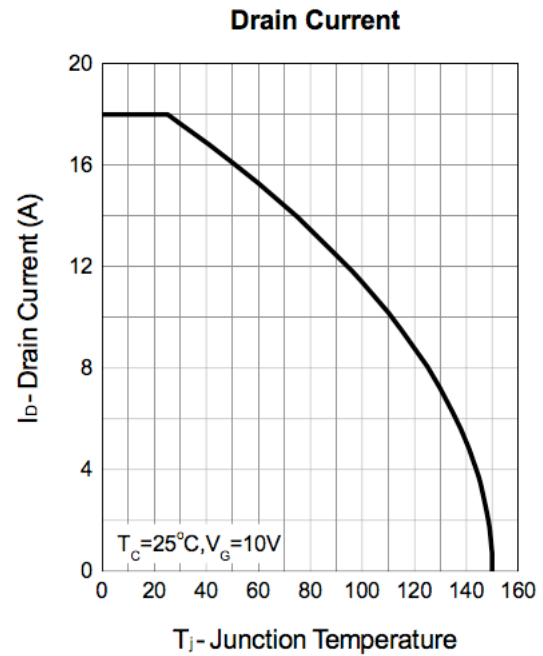
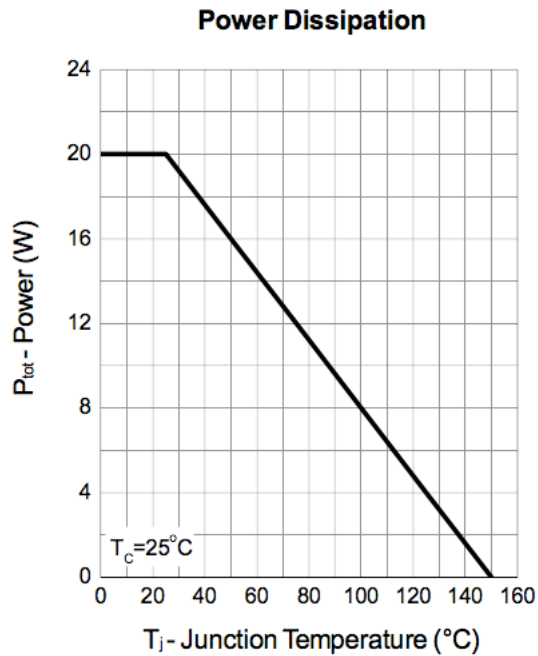


Q1 Typical Characteristics (Cont.)


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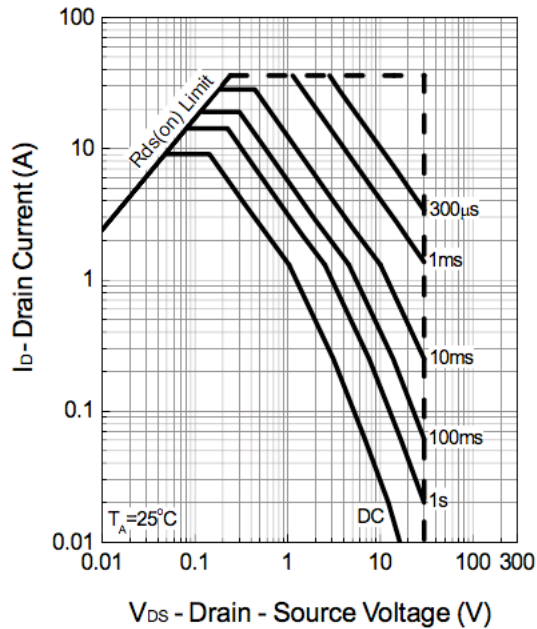


Q2 Typical Characteristics

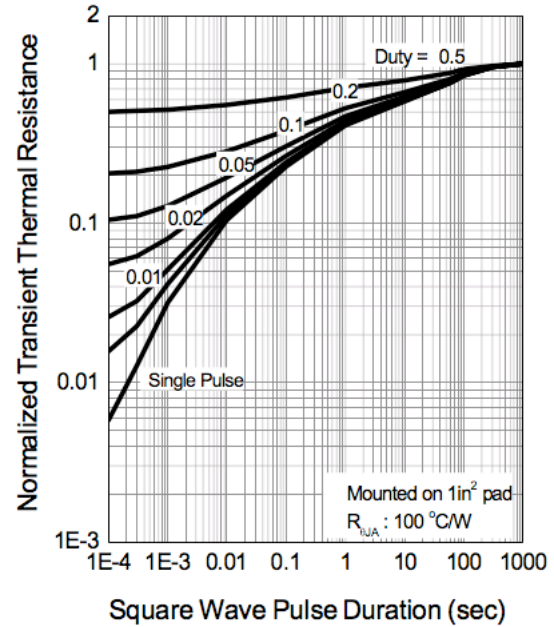


Q2 Typical Characteristics (Cont.)

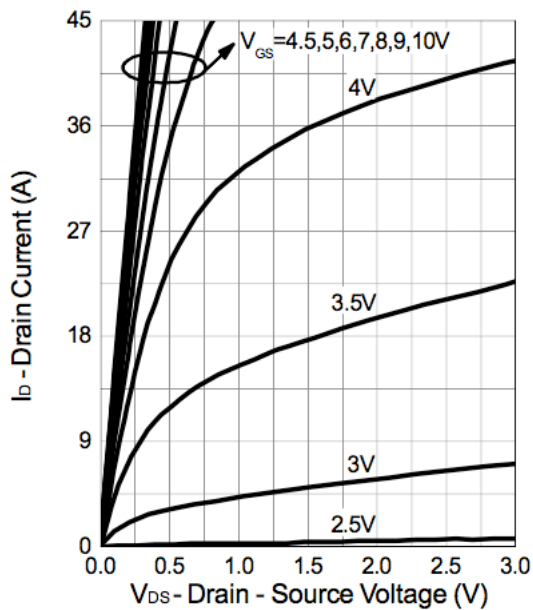
Safe Operation Area



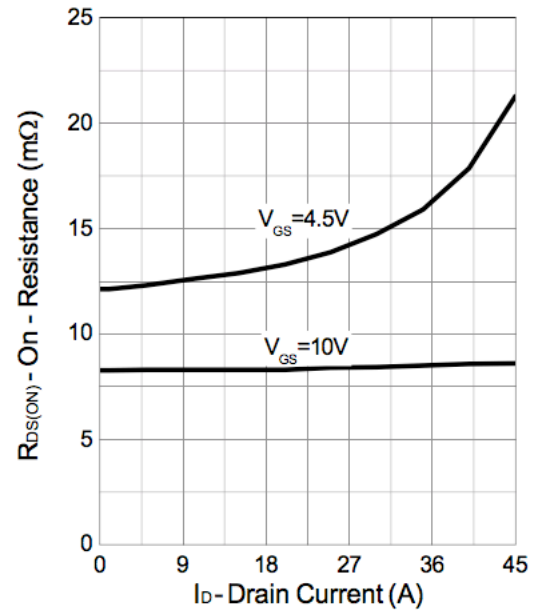
Thermal Transient Impedance



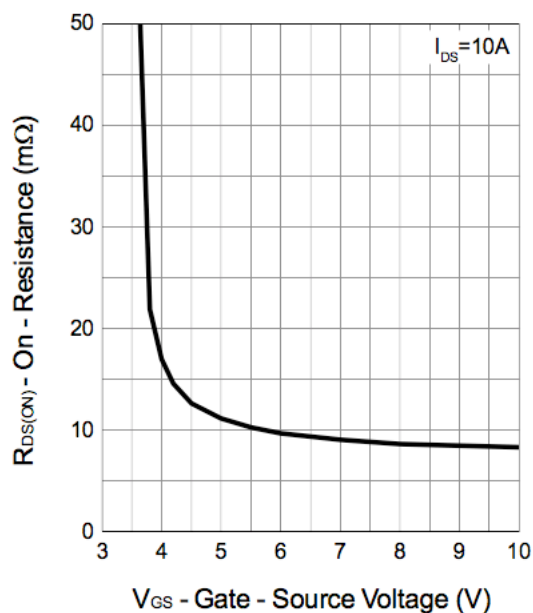
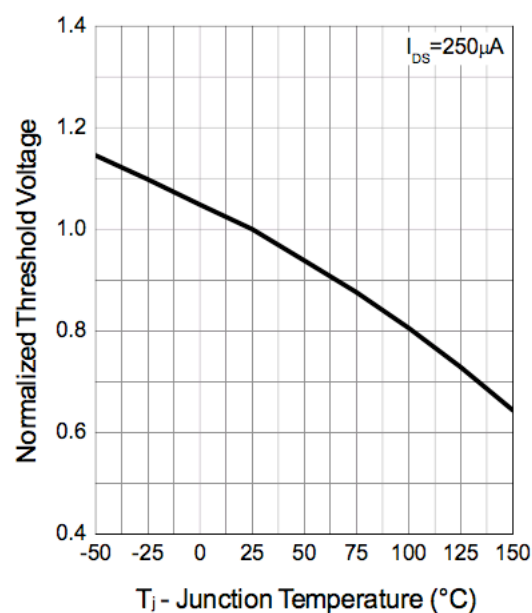
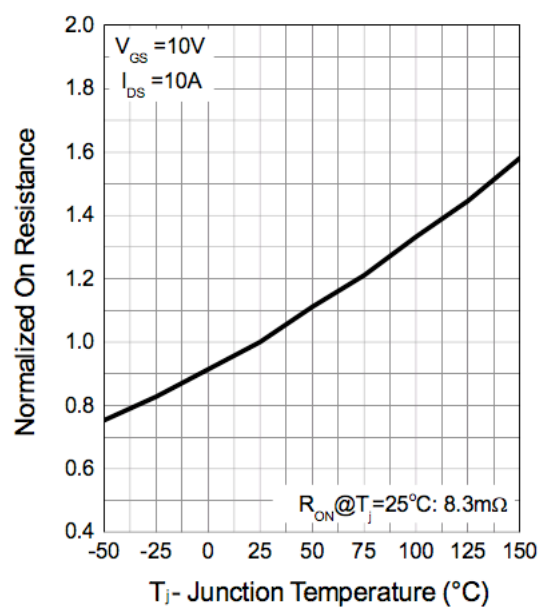
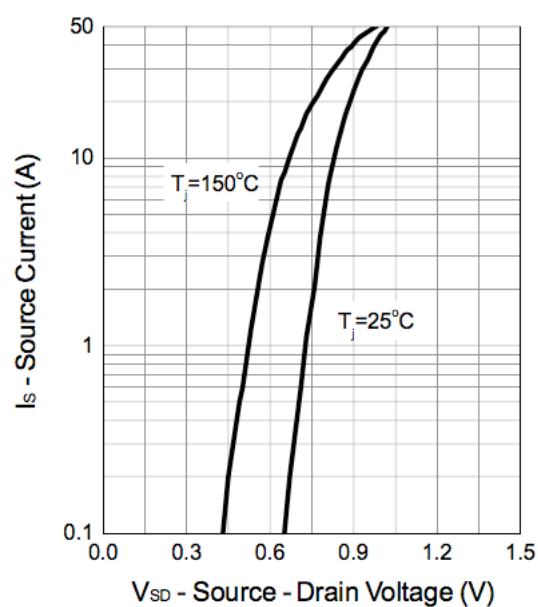
Output Characteristics



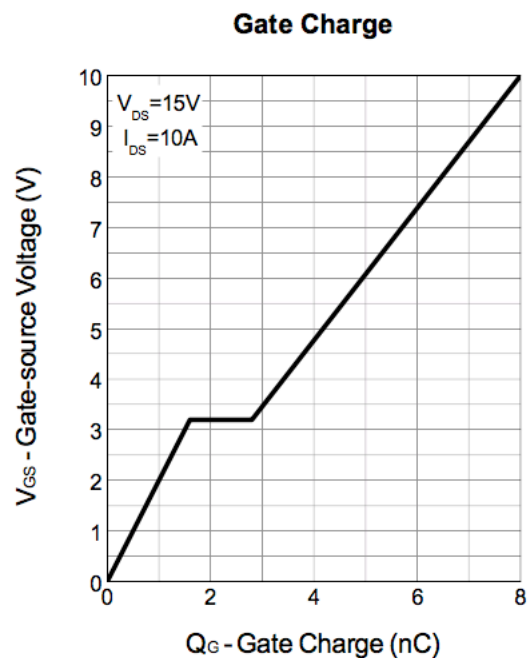
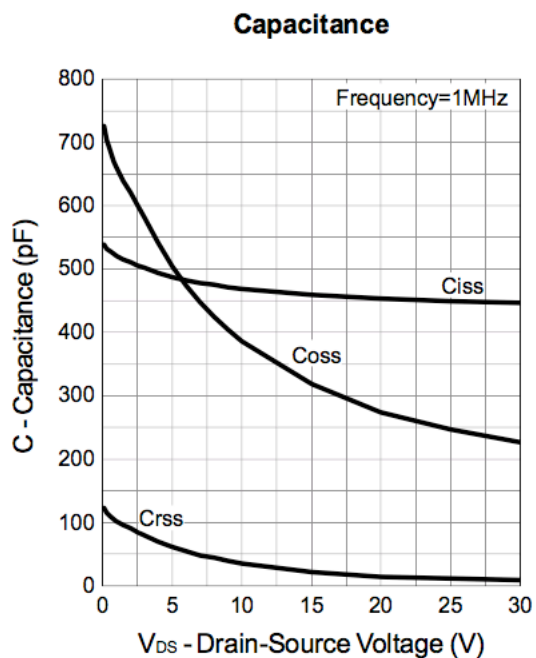
Drain-Source On Resistance



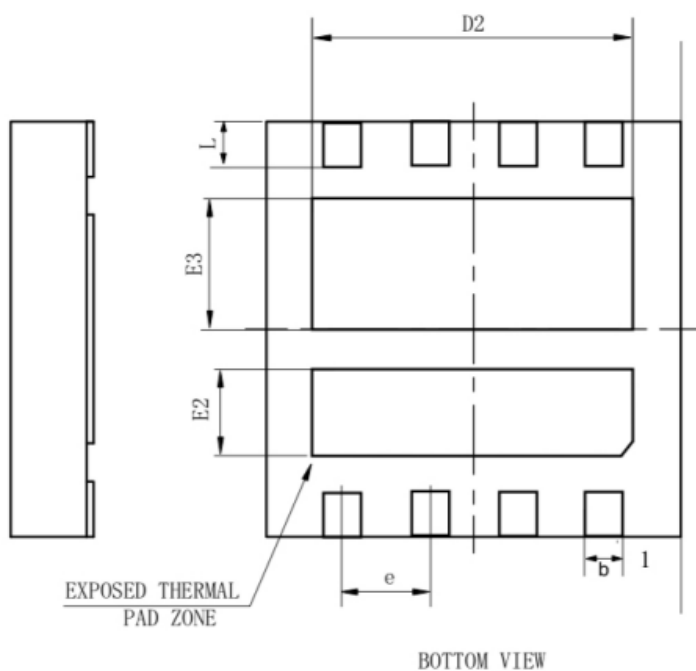
Q2 Typical Characteristics (Cont.)

Gate-Source On Resistance

Gate Threshold Voltage

Drain-Source On Resistance

Source-Drain Diode Forward


Q2 Typical Characteristics (Cont.)



Packaging information



SYMBOL	MILLIMETER		
	MIN	MID	MAX
A	0.70	0.75	0.80
A1	—	0.02	0.05
b	0.25	0.30	0.35
c	0.18	0.20	0.25
D	3.20	3.30	3.40
D2	2.50	2.60	2.70
E	3.20	3.30	3.40
E2	0.65	0.70	0.75
E3	0.95	1.05	1.15
e	0.70 BSC		
L	0.30	0.35	0.40

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